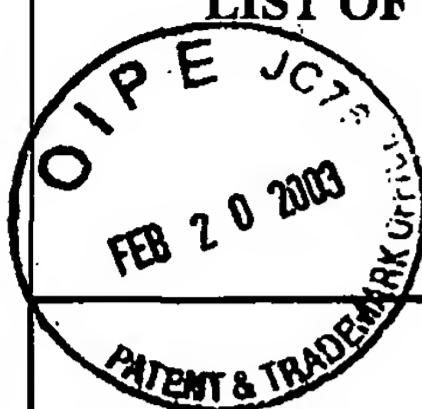


<b>LIST OF REFERENCES CITED BY APPLICANT</b>  (Use several sheets if necessary)		ATTY DOCKET NO. 618-1018	APPLICATION NO 10/085,100
		APPLICANT Enric AMOROS et al.	
		FILING DATE March 1, 2002	GROUP 3743


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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MR	AA	5,059,852	10/22/1991	Meury	310	339	
MB	AB	4,608,508	08/26/1986	Ohnishi	310	339	
AC							
AD							
AE							
AF				RECEIVED FEB 24 2003			
AG				TECHNOLOGY CENTER R3700			
AH							
AI							

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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
MB	AJ	JP 11-63498	03/05/1999	Japan w/Eng. Abstract			YES NO
MB	AK	JP 05-66014	03/19/1993	Japan w/Eng. Abstract	1		
AL							
AM							
AN							
AO							

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	AP	
	AQ	
	AR	

EXAMINER	MARK U RUDD PRIMARY EXAMINER ART UNIT 210	DATE CONSIDERED
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9-22-04

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Sheet 1 of 1

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ATTY DOCKET NO.  
618-1018

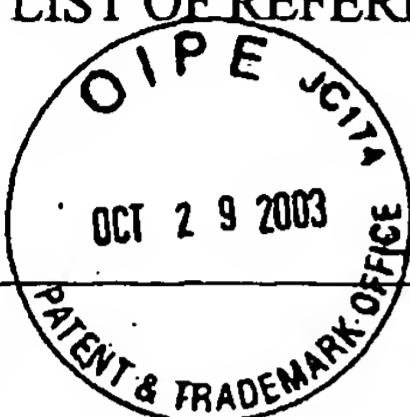
APPLICATION NO.  
10/085,100

APPLICANT  
Enric AMOROS et al.

FILING DATE  
March 1, 2002

GROUP  
3743

LIST OF REFERENCES CITED BY APPLICANT  
(Use several sheets if necessary)



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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MB	A01	3,829,737	8/13/1974	Johnsson	317	81	
	A02						
	A03						
	A04						
	A05						
	A06						
	A07						
	A08						
	A09						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	YES	NO
	B01								
	B02								
	B03								
	B04								
	B05								

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

C01	
C02	
C03	

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<p style="text-align: center;">O P E R A T I O N S</p> <p style="text-align: center;">LIST OF REFERENCES CITED BY APPLICANT</p> <p style="text-align: center;">(Use several sheets if necessary)</p> <p style="text-align: center;">NOV 04 2002</p> <p style="text-align: center;">U.S. PATENT &amp; TRADEMARK OFFICE</p>				ATTY. DOCKET NO. 618-1018	APPLICATION NO. 10/085,100		
				APPLICANT Enric AMOROS et al.			
				FILING DATE March 1, 2002	GROUP 3743		
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
AB	US 2002/0136996	9/26/02	Ichikawa et al.	431	153		
AB	6,106,277	8/22/00	Xie	431	153		
AC							
AD							
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AH							
AI							
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	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
AB	AJ JP 2002-54814	2/20/02	Japan w/Eng. Abstract			YES	NO
AB	AK JP 2001-343122	12/14/01	Japan w/Eng. Abstract				
AL							
AM							
AN							
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)							
AO							
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EXAMINER <i>MARK U. BUDD</i> PRIMARY EXAMINER	ART UNIT 212			DATE CONSIDERED		9-22-04	
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<p style="text-align: center;"><b>LIST OF REFERENCES CITED BY APPLICANT</b> (Use several sheets if necessary)</p> <p style="text-align: center;">MAY 09 2002</p> <p style="text-align: center;">JC76</p>				ATTY. DOCKET NO.	APPLICATION NO.		
				618-1018	10/085,100		
				APPLICANT			
				Enric AMOROS et al.			
FILING DATE	GROUP						
March 1, 2002	3743						
<b>U.S. PATENT DOCUMENTS</b>							
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MM	AA 6,116,892	09/2000	Yang	431	153		
	AB 6,106,277	08/2000	Xie	431	153		
	AC 6,102,689	08/2000	Man	431	153		
	AD 6,099,298	08/2000	Potskhishvili et al.	431	153		
	AE 6,099,297	08/2000	Chan	431	153		
	AF 6,099,296	08/2000	Wang	431	153		
	AG 6,095,796	08/2000	Sung	431	153		
	AH 6,095,795	08/2000	Potskhishvili et al.	431	153		
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	AL 6,077,070	06/2000	Doucet et al.	431	153		
	AM 6,077,069	06/2000	Fairbanks et al.	431	153		
	AN 6,074,198	06/2000	Rogelet	431	153		
	AO 6,065,958	05/2000	Adams et al.	431	153		
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	AQ 6,045,354	04/2000	McDonough et al.	431	153		
	AR 6,010,328	01/2000	Sung	431	153		
	AS 5,980,239	11/1999	Doucet et al.	431	153		
	AT 5,927,962	07/1999	Amoros Nollas et al.	431	255		
	AU 5,854,530	12/1998	LaForest et al.	310	339		
	AV 5,788,474	08/1998	Chung et al.	431	153		
	AW 5,642,993	07/1997	McDonough et al.	431	153		
	AX 5,636,979	06/1997	McDonough et al.	431	153		
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	BA 5,487,657	01/1996	Fairbanks et al.	431	153		
	BB 5,435,719	07/1995	McDonough et al.	431	153		
<p>EXAMINER</p> <p>MARK U. BURG</p> <p>PRIMARY EXAMINER</p>				<p>DATE CONSIDERED</p> <p>9-72-04</p>			
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<p style="text-align: center;"><b>LIST OF REFERENCES CITED BY APPLICANT</b>  <small>(Use several sheets if necessary)</small></p> <p style="text-align: center;">MAY 09 2002 JC78</p> <p style="text-align: center;"><i>SEARCHED</i> <i>INDEXED</i> <i>MAILED</i></p>				ATTY. DOCKET NO.	APPLICATION NO.	
				618-1018	10/085,100	
				APPLICANT		
				Enric AMOROS et al.		
FILING DATE	GROUP					
March 1, 2002	3743					
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*EXAMINER'S INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
JKS	BC 5,417,571	05/1995	Kvalseth	431	153	
	BD 5,417,563	05/1995	Cirami	431	153	
	BE 5,262,697	11/1993	Meury	310	339	
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	BH 5,178,532	01/1993	Frigiere	431	254	
	BI 5,171,143	12/1992	Sohn	431	153	
	BJ 5,125,829	06/1992	McDonough et al.	431	255	
	BK 5,092,764	03/1992	McDonough et al.	431	277	
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	BR 3,898,534	08/1975	Mohr	317	81	
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	BT 3,817,691	06/1974	Tatsumi	431	255	
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JKS	BW 3,457,461	07/1969	Steinke et al.	317	81	
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						YES
JKS	BX 6-249438	09/1994	Japan			X Abs
JKS	BY 60-89625	05/1985	Japan			X Abs
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)</b>						
	BZ					
EXAMINER	<i>MARK A. BUDD</i> PRIMARY EXAMINER			DATE CONSIDERED		9-72-04
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